

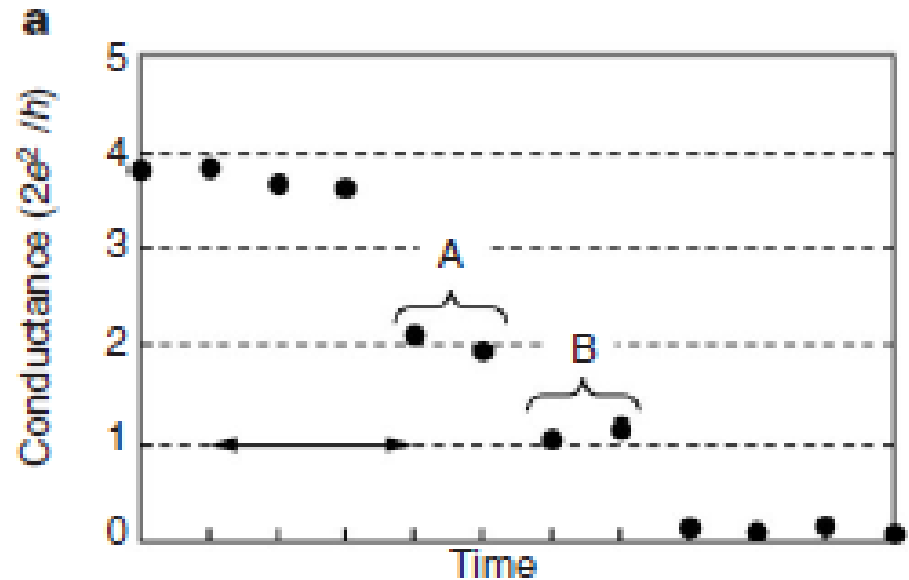
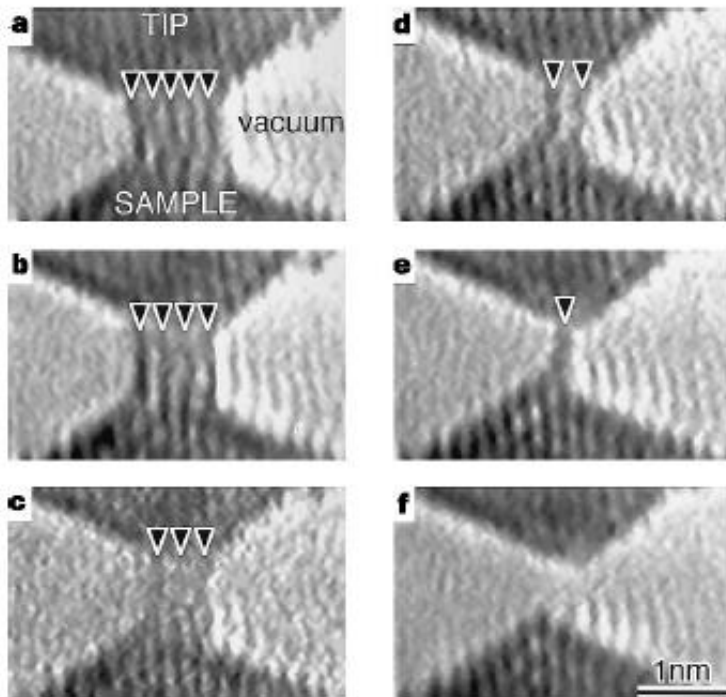
Electronic transport calculation methods in OpenMX

- Electronic transport in nano-scale materials:
- Experiments
- Nonequilibrium Green function method
 - From a scattering problem
 - Keldysh method
- Applications

Taisuke Ozaki (ISSP, Univ. of Tokyo)
Nov. 23rd, OpenMX hands-on workshop in KAIST

Quantum conductance in gold nanowires

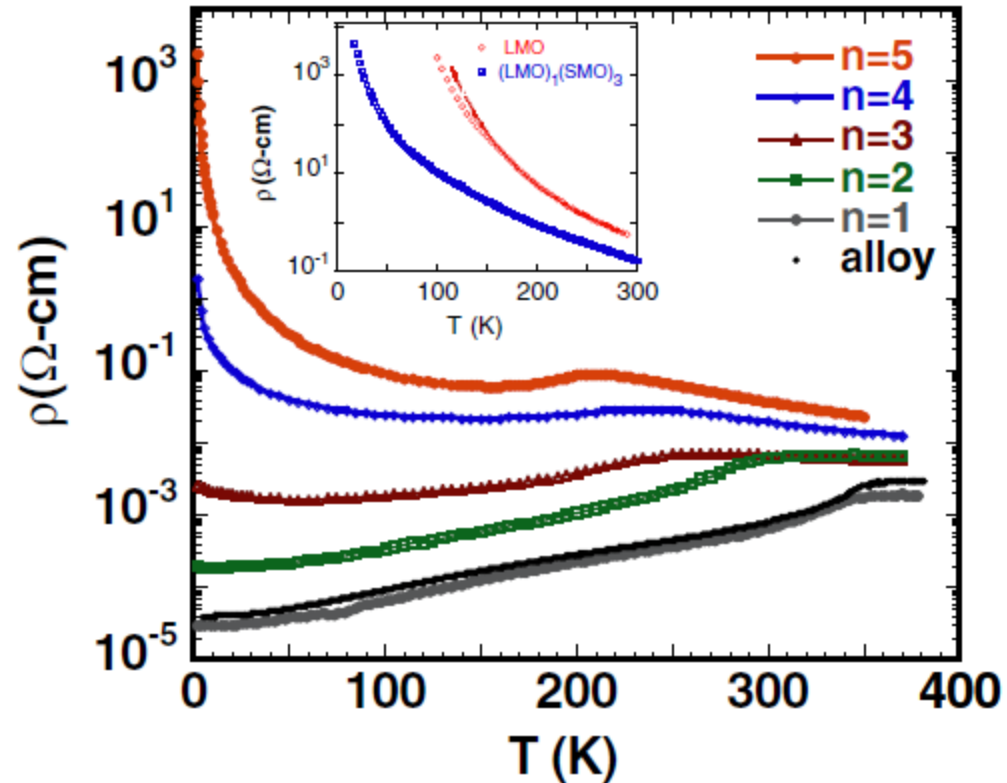
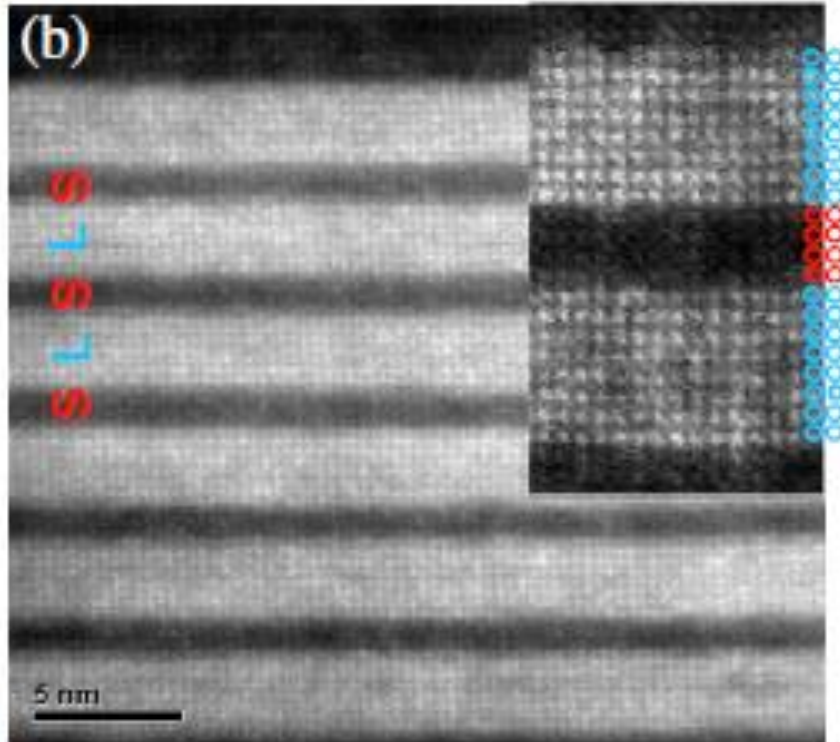
After contacting two gold structures, gradually the two structures are pulled along the axial direction. Then, the bridging region becomes gradually thinner. Along with the structural change, the conductance changes stepwise.



Takayanagi et al., Nature **395**, 780 (1998).

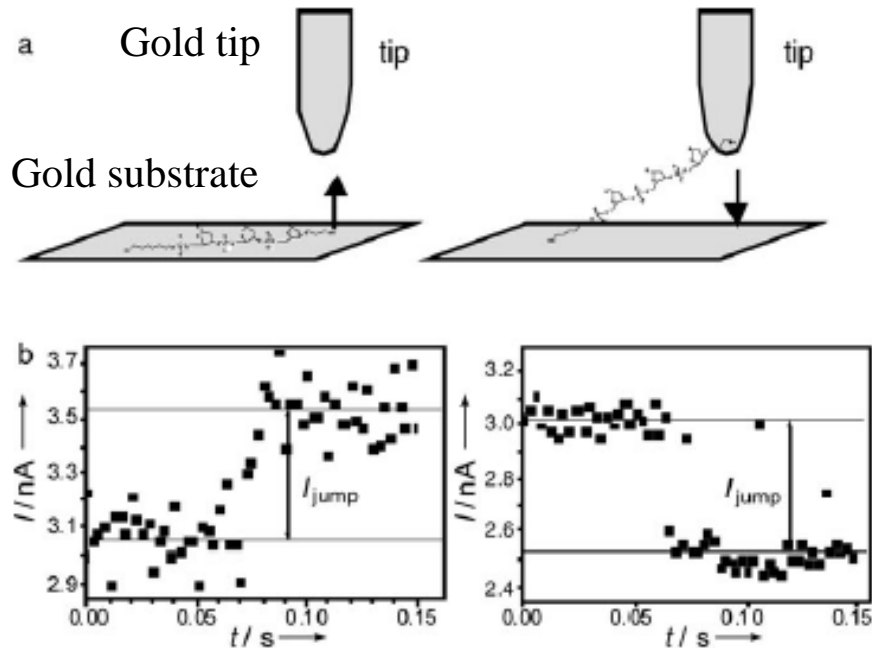
(LaMnO₃)_{2n}/(SrMnO₃)_n superlattice

Depending on the number of layers, the system exhibits a metal-insulator transition. $n < 3$ metal, $3 \leq n$ insulator

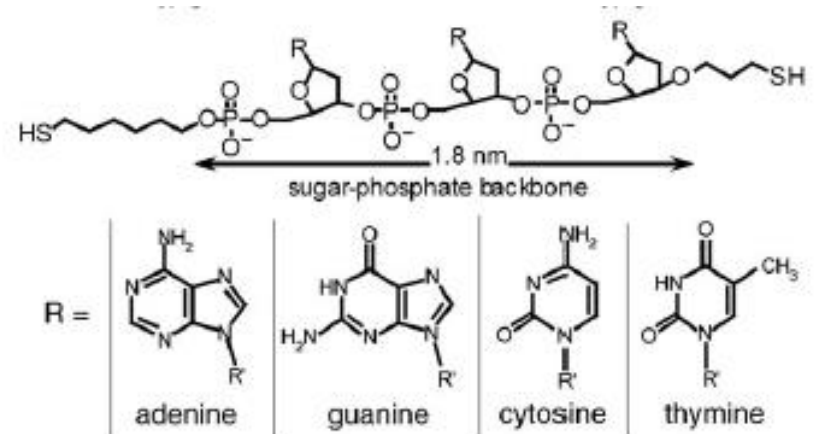
Bhattacharya et al., PRL **100**, 257203 (2008)

Transport in a single strand DNA molecule

Adsorption Detachment



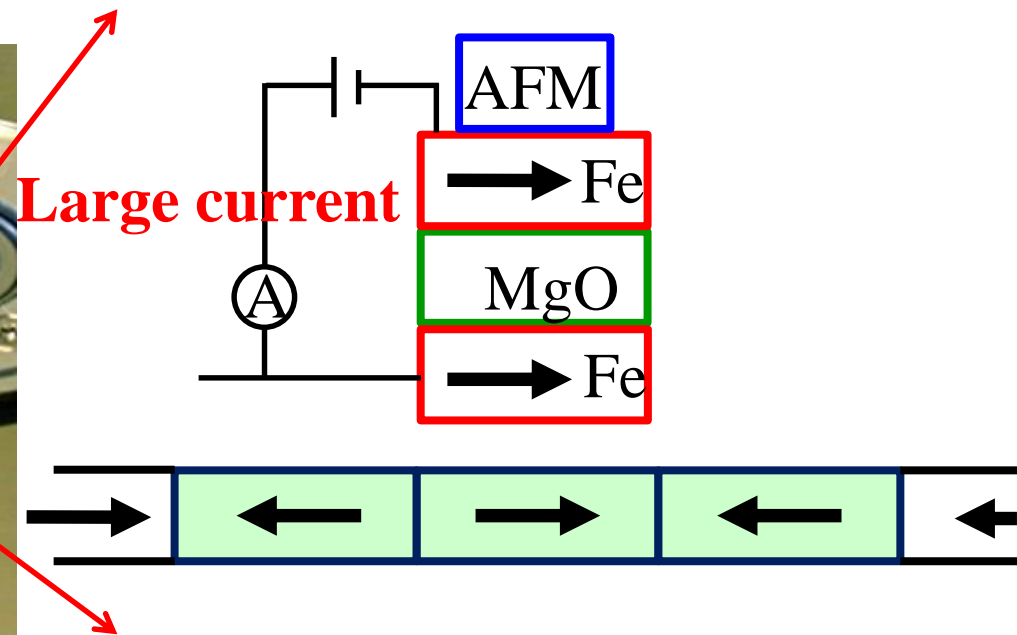
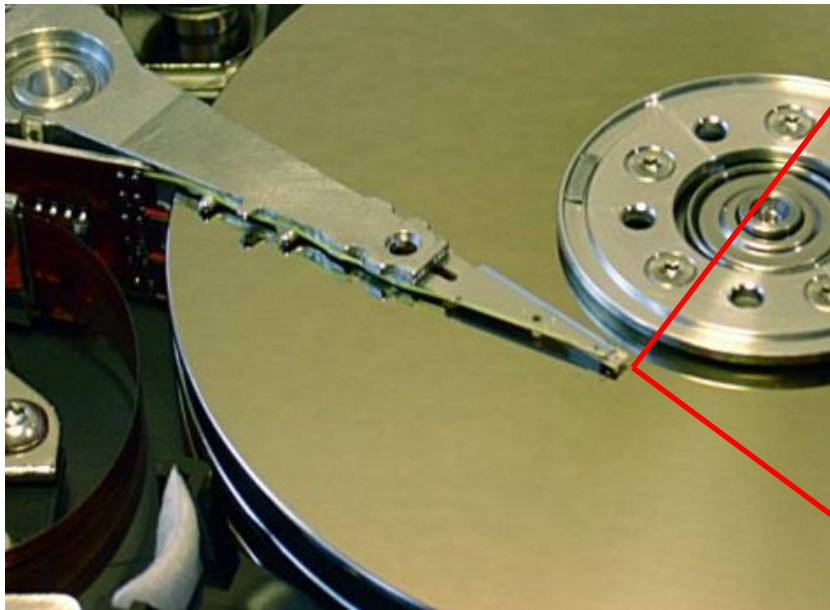
Molecular structure of a single strand DNA molecule



The current jumps when the molecule adsorbs and detaches.

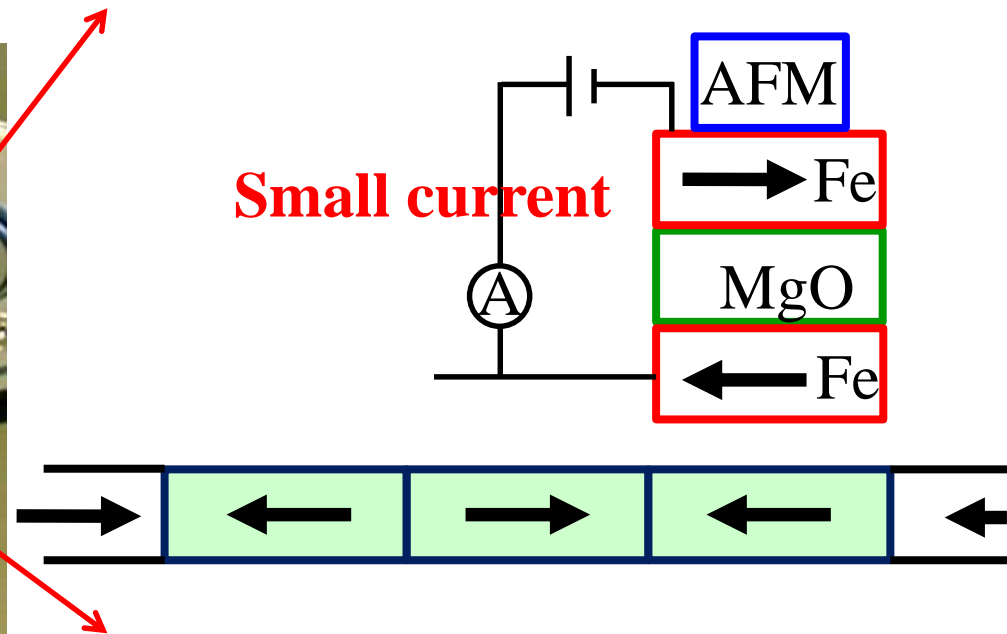
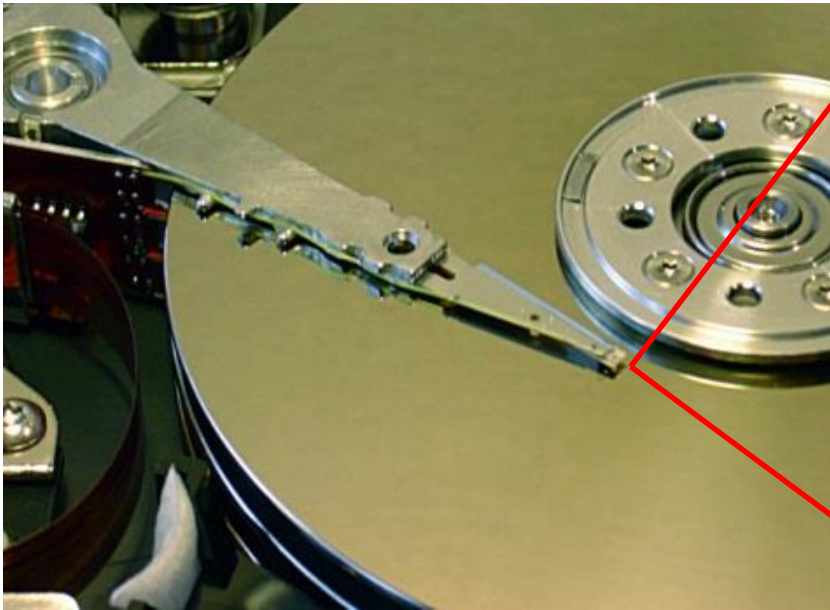
Application of tunneling magnet resistance (TMR) effect

A device used for a hard disk head is based on a tunneling magnet resistance (TMR) effect, in which the tunneling current strongly depends on the relative spin direction of two ferromagnetic regions.



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Nonequilibrium Green function methods

1961 Schwinger

Perturbation theory for $-\infty$ to $t=\infty$

1965 Keldysh

Keldysh Green function method

1972 Caroli et al.,

Application of the Keldysh Green function method

2002 Brandbyge et al.,

Development of Transiesta (ATK)

Potential advantages of the NEGF method

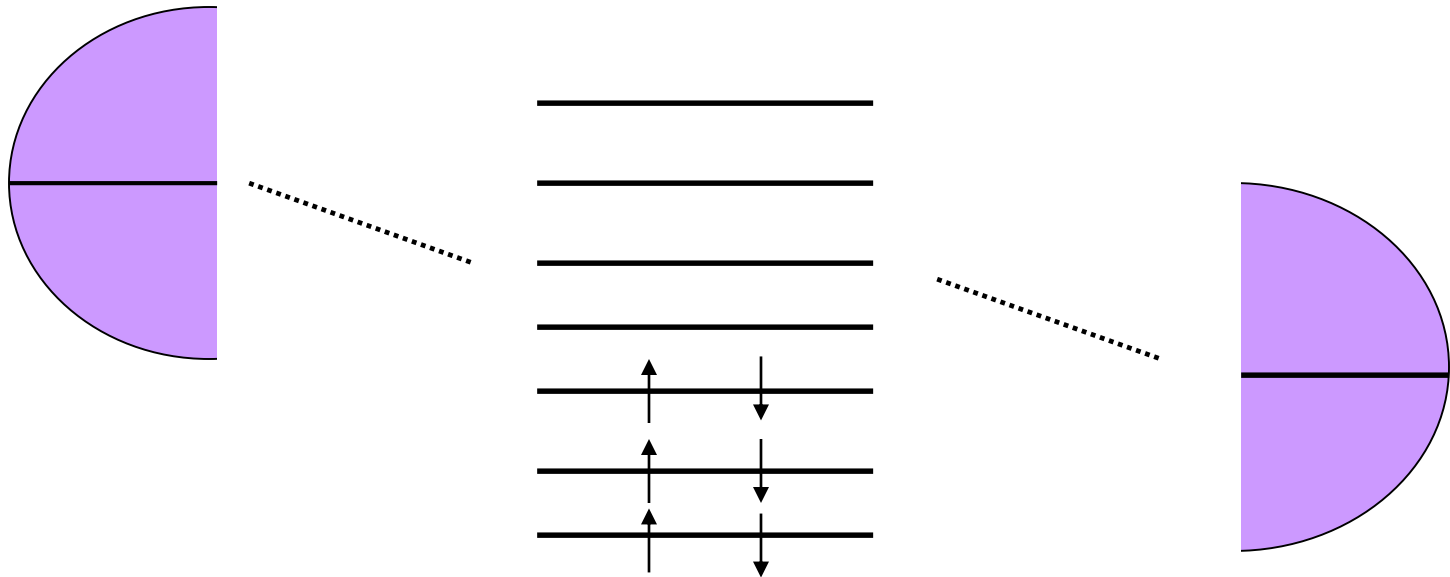
1. The source and drain contacts are treated based on the same theoretical framework as for the scattering region.
2. The electronic structure of the scattering region under a finite source-drain bias voltage is self-consistently determined by combining with first principle electronic structure calculation methods such as the density functional theory (DFT) and the Hartree-Fock (HF) method.
3. Many body effects in the transport properties, e.g., electron-phonon
4. Its applicability to large-scale systems can be anticipated, since the NEGF method relies practically on the locality of basis functions in real space, resulting in computations for sparse matrices.

Derivation of the NEGF method

1. From a scattering problem
2. From Keldysh Green function

Within one-particle picture, both the methods give the same framework.

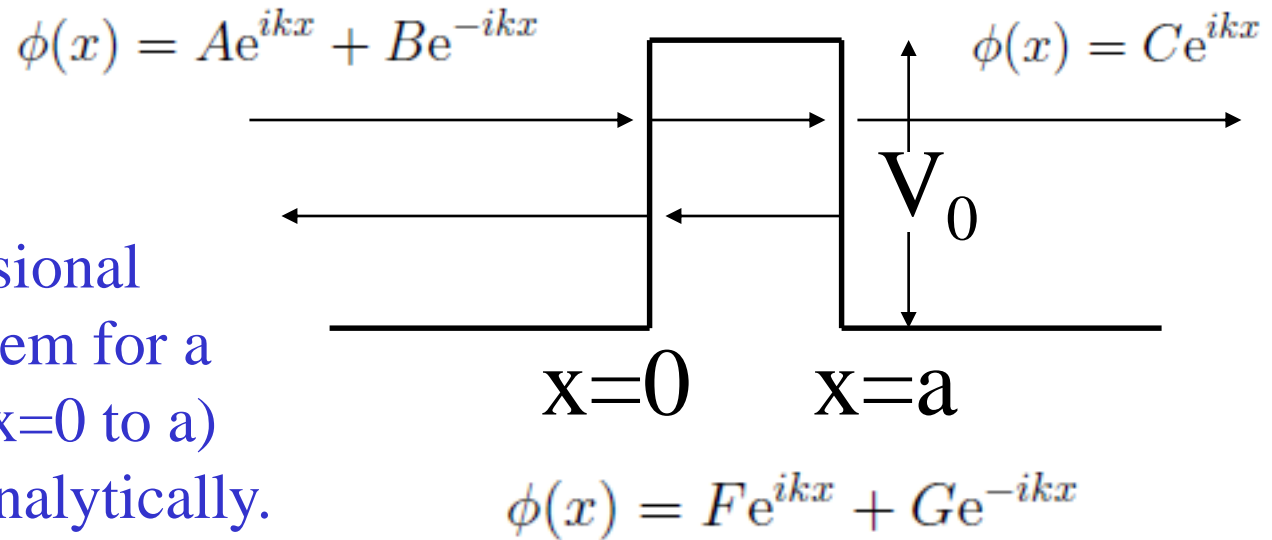
System connected to two reservoirs with different chemical potential



1. The left and right reservoirs are infinitely large and in thermo-equilibrium with **different chemical potential**.
2. They are connected via a small central region.
3. The total system may be in a non-equilibrium steady state that electrons flow steadily from the left to right.

One-dimensional scattering problem

The one-dimensional scattering problem for a potential wall ($x=0$ to a) can be solved analytically.



$$V_0 < \varepsilon$$

Reflection

$$\left| \frac{B}{A} \right|^2 = \left\{ 1 + \frac{4\varepsilon(\varepsilon - V_0)}{V_0^2 \sin^2(\kappa a)} \right\}^{-1}$$

Transmittance

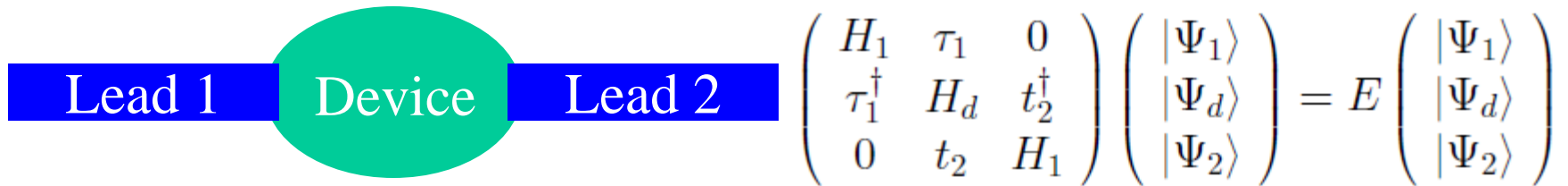
$$\left| \frac{C}{A} \right|^2 = \left\{ 1 + \frac{V_0^2 \sin^2(\kappa a)}{4\varepsilon(\varepsilon - V_0)} \right\}^{-1}$$

$$\varepsilon < V_0 \text{ (Tunnel effect)}$$

$$\left| \frac{C}{A} \right|^2 = \left\{ 1 + \frac{V_0^2 \sinh^2(\alpha a)}{4\varepsilon(V_0 - \varepsilon)} \right\}^{-1}$$

$$\varepsilon = \frac{\hbar^2}{2m} \kappa^2$$

Generalization of scattering problem in a quasi 1D



(1) Assume that the wave function of the isolated lead is known.

$$H_1|\phi_{1,n}\rangle = E|\phi_{1,n}\rangle$$

(3) By putting the whole wave function in the step2 into the Schroedinger eq., we obtain the following equations:

The whole wave function can be written by ϕ .

(2) Assume that the whole wave function of the total system can be given by

$$\begin{pmatrix} |\Psi_1\rangle \\ |\Psi_d\rangle \\ |\Psi_2\rangle \end{pmatrix} = \begin{pmatrix} |\phi_{1,n}\rangle + |\chi_1\rangle \\ |\chi_d\rangle \\ |\chi_2\rangle \end{pmatrix}$$

$$|\Psi_1\rangle = (1 + g_1\tau_1 G_d\tau_1^\dagger) |\phi_{1,n}\rangle$$

$$|\Psi_d\rangle = G_d\tau_1^\dagger |\phi_{1,n}\rangle$$

$$|\Psi_2\rangle = g_2\tau_2 G_d\tau_1^\dagger |\phi_{1,n}\rangle$$

Charge density in the device

The charge density of the device can be calculated by considering the contribution produced with the incident wave function.

$$|\Psi_{d,n}^{(1)}\rangle = G_d \tau_1^\dagger |\phi_{1,n}\rangle$$

All the contributions are summed up with the Fermi function.

$$\begin{aligned} \rho^{(1)} &= \int_{-\infty}^{\infty} dE \sum_n f(E, \mu_1) \delta(E - E_n) |\Psi_{d,n}^{(1)}\rangle \langle \Psi_{d,n}^{(1)}| \\ &= \int_{-\infty}^{\infty} dE f(E, \mu_1) \sum_n \delta(E - E_n) G_d \tau_1^\dagger |\phi_{1,n}\rangle \langle \phi_{1,n}| \tau_1 G_d^\dagger \\ &= \int_{-\infty}^{\infty} dE f(E, \mu_1) G_d \tau_1^\dagger \left(\sum_n \delta(E - E_n) |\phi_{1,n}\rangle \langle \phi_{1,n}| \right) \tau_1 G_d^\dagger \\ &= \int_{-\infty}^{\infty} dE f(E, \mu_1) G_d \tau_1^\dagger \frac{a_1}{2\pi} \tau_1 G_d^\dagger \quad \Gamma_1 = \tau_1^\dagger a_1 \tau_1 \\ &= \int_{-\infty}^{\infty} dE f(E, \mu_1) G_d \Gamma_1 G_d^\dagger \end{aligned}$$

Adding the contributions from each lead yields

$$\rho = \frac{2}{2\pi} \sum_i \int_{-\infty}^{\infty} dE f(E, \mu_i) G_d \Gamma_i G_d^\dagger$$

Depending on the chemical potential, the contribution of each lead varies.

Flux of probability density (1)

In the nonequilibrium steady state, assuming that the probability density conserves, and we evaluate the flux of the probability density using the time-dependent Schroedinger equation.

$$i\hbar \frac{\partial}{\partial t} \begin{pmatrix} |\Psi_1\rangle \\ |\Psi_d\rangle \\ |\Psi_2\rangle \end{pmatrix} = \begin{pmatrix} H_1 & \tau_1 & 0 \\ \tau_1^\dagger & H_d & t_2^\dagger \\ 0 & t_2 & H_2 \end{pmatrix} \begin{pmatrix} |\Psi_1\rangle \\ |\Psi_d\rangle \\ |\Psi_2\rangle \end{pmatrix}$$

The time evolution of the integrated probability density is given by

$$\begin{aligned} \frac{\partial}{\partial t} \langle \Psi_d | \Psi_d \rangle &= \frac{\partial \langle \Psi_d |}{\partial t} |\Psi_d\rangle + \langle \Psi_d | \frac{\partial |\Psi_d\rangle}{\partial t} \\ &= \frac{i}{\hbar} [(\langle \Psi_2 | \tau_2 + \langle \Psi_d | H_d + \langle \Psi_1 | \tau_1) |\Psi_d\rangle \\ &\quad - \langle \Psi_d | (\tau_1^\dagger |\Psi_1\rangle + H_d |\Psi_d\rangle + \tau_2^\dagger |\Psi_2\rangle)] \\ &= \frac{i}{\hbar} [(\langle \Psi_1 | \tau_1 |\Psi_d\rangle - \langle \Psi_d | \tau_1^\dagger |\Psi_1\rangle) + (\langle \Psi_2 | \tau_2 |\Psi_d\rangle - \langle \Psi_d | \tau_2^\dagger |\Psi_2\rangle)] \end{aligned}$$

Each term can be regarded as the contribution from each lead k.

$$i_k = -\frac{ie}{\hbar} (\langle \Psi_k | \tau_k |\Psi_d\rangle - \langle \Psi_d | \tau_k^\dagger |\Psi_k\rangle)$$

Thus, we have

$$\sum_k i_k = 0$$

Flux of probability density (2)

$$i_k = -\frac{ie}{\hbar} \left(\langle \Psi_k | \tau_k | \Psi_d \rangle - \langle \Psi_d | \tau_k^\dagger | \Psi_k \rangle \right)$$

where the sign of the flux of the probability density i_k is taken so that the direction from the lead k to the device can be positive.



i_1 Flux from the lead 1 to the device \rightarrow
 i_2 Flux from the lead 2 to the device \leftarrow

In other words, in the steady state the flux (i_1) of the probability density from the lead 1 to the device is equal to that ($-i_2$) from the device to the lead 2. Note that the sign of i_2 is opposite to that of i_1 when they are seen as current.

Current (1)

Ψ_d and Ψ_2 can be written by the wave function of the isolated lead 1.

$$|\Psi_d\rangle = G_d \tau_1^\dagger |\phi_{1,n}\rangle \quad |\Psi_2\rangle = g_2 \tau_2 G_d \tau_1^\dagger |\phi_{1,n}\rangle$$

Then, the current from the leads 1 to 2 is given by

$$\begin{aligned} i_{2 \text{ from } 1} &= -\frac{ie}{\hbar} \left(\langle \psi_2 | \tau_2 | \psi_d \rangle - \langle \psi_d | \tau_2^\dagger | \psi_2 \rangle \right) \\ &= -\frac{ie}{\hbar} \left(\langle \psi_{1,n} | \tau_1 G_d^\dagger \tau_2^\dagger g_2^\dagger \tau_2 G_d \tau_1^\dagger | \psi_{1,n} \rangle - \langle \psi_{1,n} | \tau_1 G_d^\dagger \tau_2^\dagger g_2 \tau_2 G_d \tau_1^\dagger | \psi_{1,n} \rangle \right) \\ &= -\frac{ie}{\hbar} \langle \psi_{1,n} | \tau_1 G_d^\dagger \tau_2^\dagger \left(g_2^\dagger - g_2 \right) \tau_2 G_d \tau_1^\dagger | \psi_{1,n} \rangle \\ &= \frac{e}{\hbar} \langle \psi_{1,n} | \tau_1 G_d^\dagger \Gamma_2 G_d \tau_1^\dagger | \psi_{1,n} \rangle \end{aligned}$$

Current (2)

Considering all the states in the lead 1, we obtain the formula of current from the leads 1 to 2 as follows:

$$\begin{aligned}
 I_{2 \text{ from } 1} &= 2\frac{e}{\hbar} \int_{E=-\infty}^{\infty} dE f(E, \mu_1) \sum_n \delta(E - E_n) \langle \psi_{1,n} | \tau_1 G_d^\dagger \Gamma_2 G_d \tau_1^\dagger | \psi_{1,n} \rangle \\
 &= \frac{2e}{\hbar} \int_{E=-\infty}^{\infty} dE f(E, \mu_1) \sum_{m,n} \delta(E - E_n) \langle \psi_{1,n} | \tau_1 | m \rangle \langle m | G_d^\dagger \Gamma_2 G_d \tau_1^\dagger | \psi_{1,n} \rangle \\
 &= \frac{2e}{\hbar} \int_{E=-\infty}^{\infty} dE f(E, \mu_1) \sum_m \langle m | G_d^\dagger \Gamma_2 G_d \tau_1^\dagger \left(\sum_n \delta(E - E_n) | \psi_{1,n} \rangle \langle \psi_{1,n} | \right) \tau_1 | m \rangle \\
 &= \frac{2e}{\hbar} \int_{E=-\infty}^{\infty} dE f(E, \mu_1) \sum_m \langle m | G_d^\dagger \Gamma_2 G_d \tau_1^\dagger \frac{a_1}{2\pi} \tau_1 | m \rangle \\
 &= \frac{e}{\pi \hbar} \int_{E=-\infty}^{\infty} dE f(E, \mu_1) \text{Tr} \left(G_d^\dagger \Gamma_2 G_d \Gamma_1 \right)
 \end{aligned}$$

Adding all the contributions from each lead yields the formula:

$$I = \frac{e}{\pi \hbar} \int_{E=-\infty}^{\infty} dE (f(E, \mu_1) - f(E, \mu_2)) \text{Tr} \left(G_d^\dagger \Gamma_2 G_d \Gamma_1 \right)$$

← Transmission

Summary: from a scattering problem

The whole wave function is written by the incident wave function:

$$|\Psi_1\rangle = (1 + g_1\tau_1 G_d\tau_1^\dagger) |\phi_{1,n}\rangle$$

$$|\Psi_d\rangle = G_d\tau_1^\dagger |\phi_{1,n}\rangle$$

$$|\Psi_2\rangle = g_2\tau_2 G_d\tau_1^\dagger |\phi_{1,n}\rangle$$

The charge density in the device is given by the sum of the contributions from each lead.

$$\rho = \frac{2}{2\pi} \sum_i \int_{-\infty}^{\infty} dE f(E, \mu_i) G_d \Gamma_i G_d^\dagger$$

Considering the flux of the probability density, the current is given by

$$I = \frac{e}{\pi\hbar} \int_{E=-\infty}^{\infty} dE (f(E, \mu_1) - f(E, \mu_2)) \text{Tr} \left(G_d^\dagger \Gamma_2 G_d \Gamma_1 \right)$$

← Transmission

Conductance and transmission

Let us start an expression of current I

$$I = \frac{q}{h} \int dE T(E) [f(E - \mu_1) - f(E - \mu_2)], \quad (1)$$

where q is the elementary charge, h the Plank constant, T the transmission, f the Fermi function, μ_1 and μ_2 the chemical potentials of the left and right leads.

Our purpose is to find a relation:

$$I = \frac{V}{R} = VG, \quad (2)$$

where V is the source-drain bias voltage, R the resistance, and $G \equiv \frac{1}{R}$ is the conductance. To derive Eq. (2) based on Eq. (1), we consider a case that $\mu_1 = \mu_2 + qV = \mu + qV$ with a tiny V . Then, Eq. (1) can be approximated by

$$\begin{aligned} I &= \frac{q}{h} \int dE T(E) [f(E - (\mu + qV)) - f(E - \mu)], \\ &\simeq \int dE \left(T(\mu) + \frac{\partial T(E)}{\partial E} \Big|_{E=\mu} (E - \mu) \right) [f(E - (\mu + qV)) - f(E - \mu)] \\ &\quad + \int dE T(E) \left[f(E - \mu) + \frac{\partial f(E - (\mu + qV))}{\partial V} \Big|_{V=0} V - f(E - \mu) \right]. \quad (3) \end{aligned}$$

Conductance and transmission: continued

Since the first term in the R.H.S of Eq. (3) is zero when $V \rightarrow 0$, and $\frac{\partial f(E-(\mu+qV))}{\partial V}|_{V=0} = -q\frac{\partial f(E-(\mu+qV))}{\partial E}|_{V=0}$, we obtain

$$I \simeq \frac{q^2}{h} V \int dE T(E) \left(-\frac{\partial f(E-(\mu+qV))}{\partial E} \Big|_{V=0} \right). \quad (4)$$

In case that $V \rightarrow 0$ and the electronic temperature is zero, the derivative in Eq. (4) becomes the delta function. Thus, we have

$$I \simeq V \left(T(\mu) \frac{q^2}{h} \right). \quad (5)$$

By comparing Eqs. (2) and (5), the conductance G can be related to the transmission at the chemical potential:

$$G = T(\mu) \frac{q^2}{h}. \quad (6)$$

Here we define

$$G_0 = \frac{q^2}{h}. \quad (7)$$

Using G_0 as unit, we can write

$$G = T(\mu) \quad \text{in } G_0 \quad (8)$$

System we consider

Assume that the periodicity on the bc plane, and non-periodicity along the a-axis

Thus, we can write the Bloch wave function on the bc plane

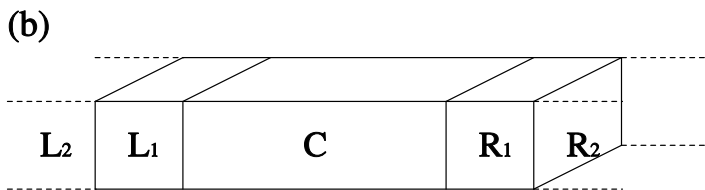
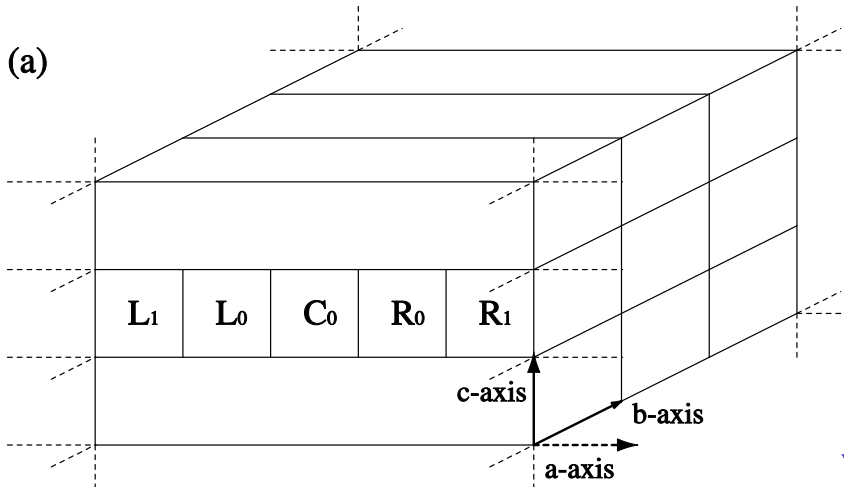
$$\psi_{\sigma\nu}^{(\mathbf{k})}(\mathbf{r}) = \frac{1}{\sqrt{N}} \sum_{\mathbf{n}} e^{i\mathbf{k} \cdot \mathbf{R}_{\mathbf{n}}} \sum_{i\alpha} c_{\sigma\nu, i\alpha}^{(\mathbf{k})} \phi_{i\alpha}(\mathbf{r} - \tau_i - \mathbf{R}_{\mathbf{n}}),$$

And, the problem can be cast to a 1D problem.

$$H_{\sigma}^{(\mathbf{k})} c_{\sigma\nu}^{(\mathbf{k})} = \varepsilon_{\sigma\nu}^{(\mathbf{k})} S^{(\mathbf{k})} c_{\sigma\nu}^{(\mathbf{k})},$$

where the Hamiltonian is given by a block tri-diagonal form:

$$H_{\sigma}^{(\mathbf{k})} = \begin{pmatrix} \ddots & \ddots & & & 0 \\ \ddots & H_{\sigma, L_1}^{(\mathbf{k})} & H_{\sigma, L_1 C}^{(\mathbf{k})} & & \\ & H_{\sigma, C L_1}^{(\mathbf{k})} & H_{\sigma, C}^{(\mathbf{k})} & H_{\sigma, C R_1}^{(\mathbf{k})} & \\ & & H_{\sigma, R_1 C}^{(\mathbf{k})} & H_{\sigma, R_1}^{(\mathbf{k})} & \ddots \\ 0 & & & \ddots & \ddots \end{pmatrix}$$



Green function of the device region

Using the block form of matrices and the following identity:

$$G_{\sigma}^{(\mathbf{k})}(Z)(ZS^{(\mathbf{k})} - H_{\sigma}^{(\mathbf{k})}) = \mathbf{I}$$

we obtain

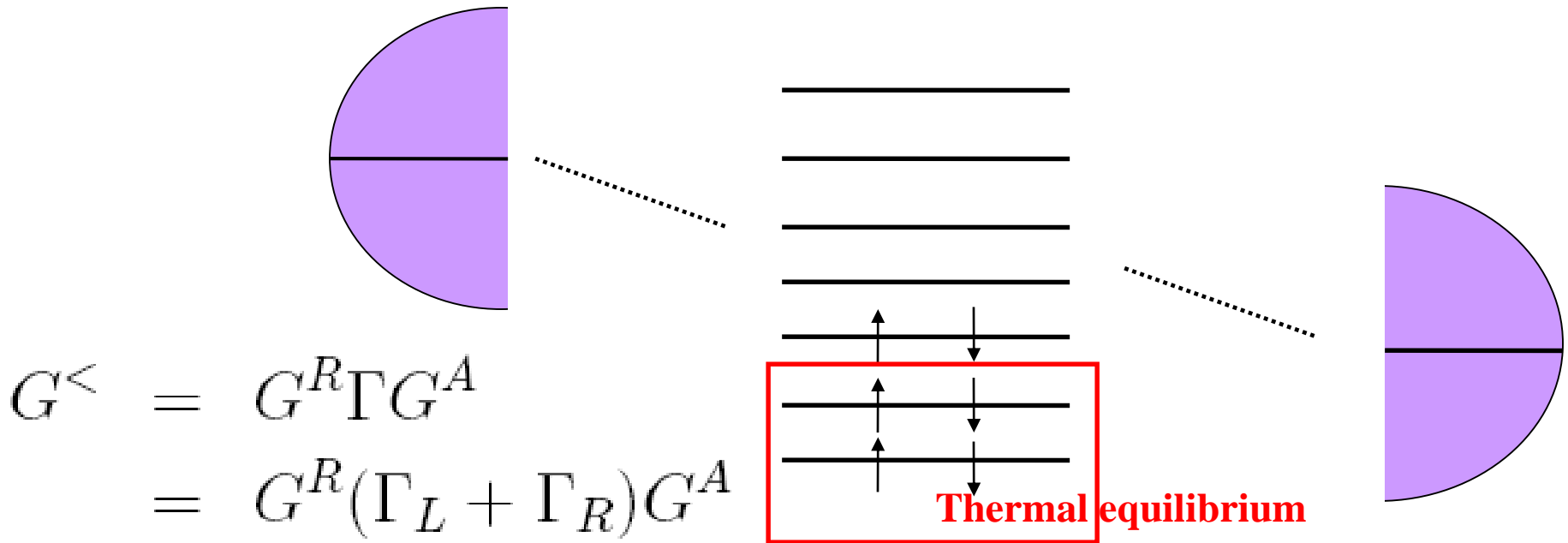
$$G_{\sigma,C}^{(\mathbf{k})}(Z) = \left(ZS_C^{(\mathbf{k})} - H_{\sigma,C}^{(\mathbf{k})} - \Sigma_{\sigma,L}^{(\mathbf{k})}(Z) - \Sigma_{\sigma,R}^{(\mathbf{k})}(Z) \right)^{-1}$$

where the self energies are explicitly given by

$$\Sigma_{\sigma,L}^{(\mathbf{k})}(Z) = (ZS_{CL_1}^{(\mathbf{k})} - H_{\sigma,CL_1}^{(\mathbf{k})}) \times \\ G_{\sigma,L}^{(\mathbf{k})}(Z)(ZS_{L_1C}^{(\mathbf{k})} - H_{\sigma,L_1C}^{(\mathbf{k})}),$$

$$\Sigma_{\sigma,R}^{(\mathbf{k})}(Z) = (ZS_{CR_1}^{(\mathbf{k})} - H_{\sigma,CR_1}^{(\mathbf{k})}) \times \\ G_{\sigma,R}^{(\mathbf{k})}(Z)(ZS_{R_1C}^{(\mathbf{k})} - H_{\sigma,R_1C}^{(\mathbf{k})}),$$

Assumption in the implementation of the NEGF method



It is assumed that the states for $m_R < m_L$ in the central part is in the thermal equilibrium. Then, the charge density can be calculated by

$$\rho = -\frac{2}{\pi} \text{Im} \int dE f_R G^R - \frac{2}{\pi} \text{Im} \int dE (f_L - f_R) G^R \Gamma_L G^A$$

Density matrix of the device region

From the previous assumption we made, the density matrix is given by the sum of the equilibrium and nonequilibrium contributions.

$$\rho_{\sigma, \mathbf{R}_n}^{(\text{neq})} = \rho_{\sigma, \mathbf{R}_n}^{(\text{eq})} + \Delta \rho_{\sigma, \mathbf{R}_n}.$$

The equilibrium contribution is given by the integration of the equilibrium Green function.

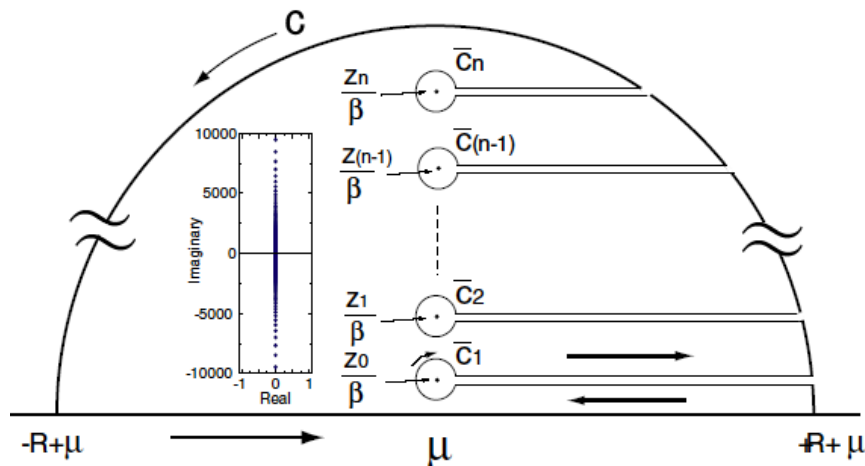
$$\rho_{\sigma, \mathbf{R}_n}^{(\text{eq})} = \frac{1}{V_c} \int_{\text{BZ}} dk^3 \left(\rho_{\sigma, +}^{(\mathbf{k})} - \rho_{\sigma, -}^{(\mathbf{k})} \right) e^{-i\mathbf{k} \cdot \mathbf{R}_n}$$

$$\rho_{\sigma, \pm}^{(\mathbf{k})} = \frac{i}{2\pi} \int_{-\infty}^{\infty} dE G_{\sigma, C}^{(\mathbf{k})}(E \pm i0^+) f(E - \mu),$$

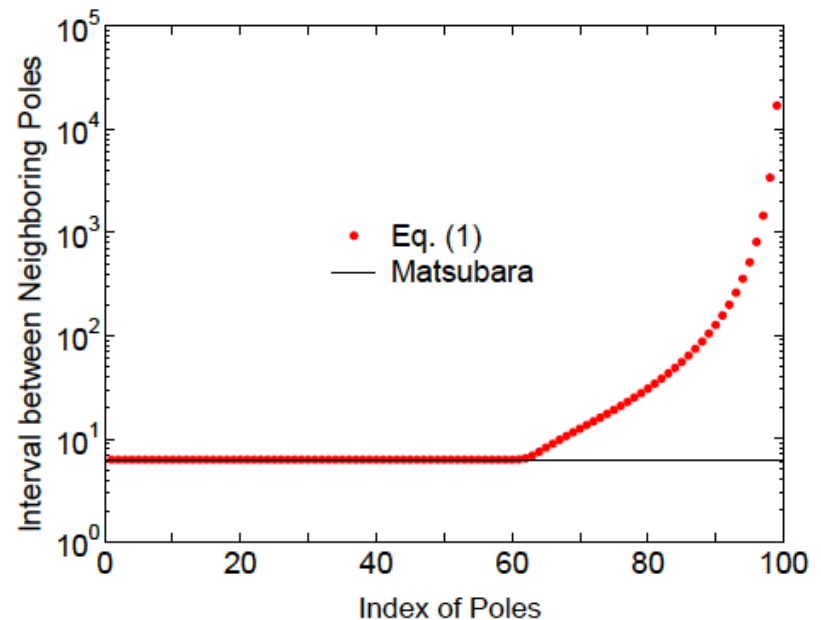
Contour integration

By expressing the Fermi function one can obtain a special distribution of poles. The distribution gives the extremely fast convergence.

$$\frac{1}{1 + \exp(x)} = \frac{1}{2} - \frac{x}{4} \left(\frac{1}{1 + \frac{(\frac{x}{2})^2}{3 + \frac{(\frac{x}{2})^2}{5 + \frac{(\frac{x}{2})^2}{\dots}}}} \right)$$



T.Ozaki, PRB 75, 035123 (2007).



Nonequilibrium density matrix

Since NEGF is a non-analytic function, the integration is performed on the real axis with a small imaginary part.

$$\Delta\rho_{\sigma,\mathbf{R}_n} = \frac{1}{V_c} \int_{\text{BZ}} dk^3 \Delta\rho_{\sigma}^{(\mathbf{k})} e^{-i\mathbf{k}\cdot\mathbf{R}_n}$$

$$\begin{aligned} \Delta\rho_{\sigma}^{(\mathbf{k})} = & \frac{1}{2\pi} \int_{-\infty}^{\infty} dE G_{\sigma,C}^{(\mathbf{k})}(E + i\epsilon) \Gamma_{\sigma,s_1}^{(\mathbf{k})}(E) \\ & \times G_{\sigma,C}^{(\mathbf{k})}(E - i\epsilon) \Delta f(E) \end{aligned}$$

$$\Gamma_{\sigma,s_1}^{(\mathbf{k})}(E) = i \left(\Sigma_{\sigma,s_1}^{(\mathbf{k})}(E + i\epsilon) - \Sigma_{\sigma,s_1}^{(\mathbf{k})}(E - i\epsilon) \right)$$

$$\Delta f(E) = f(E - \mu_{s_1}) - f(E - \mu_{s_2}).$$

Poisson eq. with the boundary condition

Poisson eq.

$$\left(\frac{d^2}{dx^2} + \frac{d^2}{dy^2} + \frac{d^2}{dz^2} \right) V_H(x, y, z) = -4\pi\rho(x, y, z)$$

FT for x-y plane

$$\left(\frac{d^2}{dz^2} - G_{\parallel} \right) V_H(G_{\parallel}, z) = -4\pi\rho(G_{\parallel}, z)$$

Discretization

$$\frac{V_H(G_{\parallel}, z_{n+1}) - 2V_H(G_{\parallel}, z_n)V_H(G_{\parallel}, z_{n-1})}{(\Delta z)^2} - \rho(G_{\parallel}, z)V_H(G_{\parallel}, z_n) = -4\pi\rho(G_{\parallel}, z_n)$$

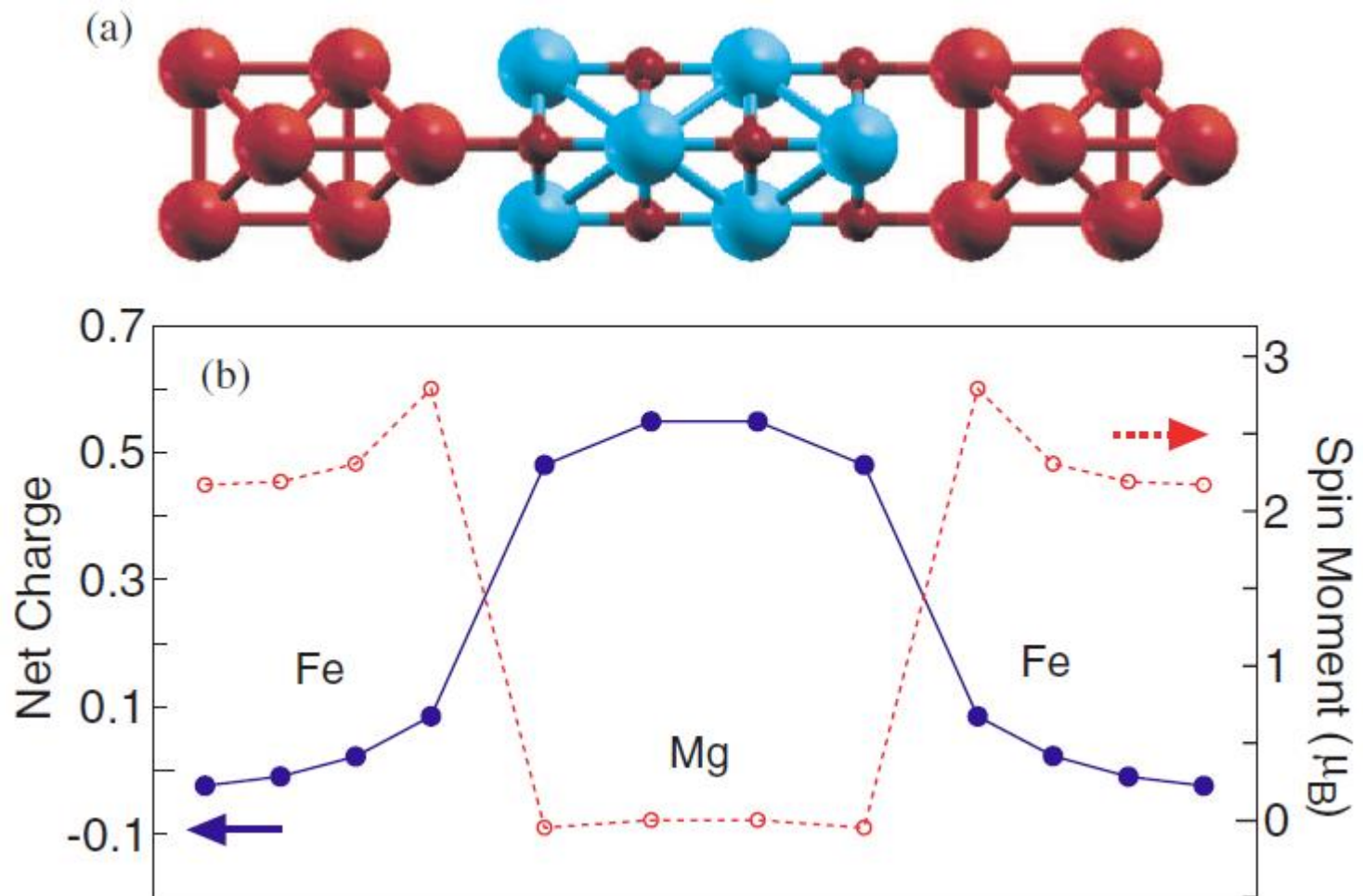
Boundary conditions: $V_H(G_{\parallel}, z_0) = 0$ $V_H(G_{\parallel}, z_N) = 0$

XY-FFT \rightarrow linear eq. \rightarrow XY-inverse FFT

Cost: $O(N_x \log(N_x)) \times O(N_y \log(N_y)) \times O(N_z)$

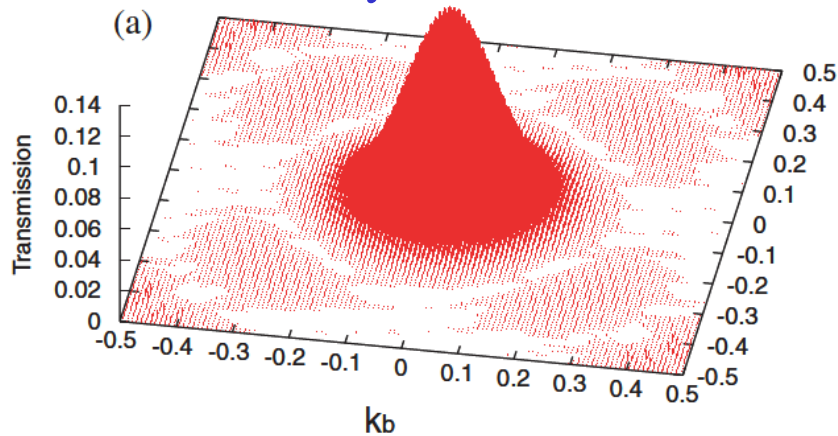
Fe|MgO|Fe (TMR device)

Fe|MgO|Fe device has been gradually used as a hard disk head.

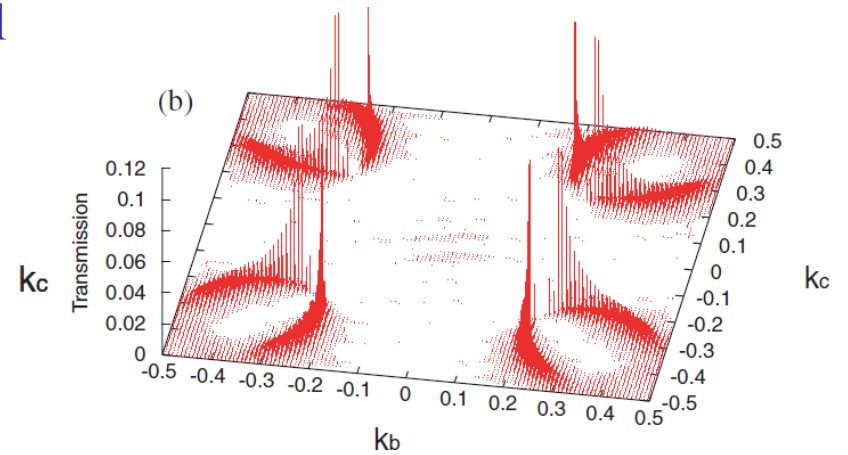


k-dependency of transmission (Fe|MgO|Fe)

up for $\uparrow\uparrow$
mainly comes from s-orbital

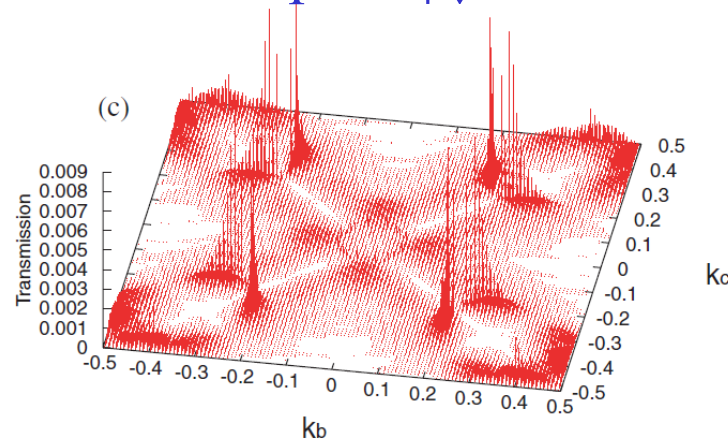


down for $\downarrow\downarrow$



mainly comes from d-orbital

up for $\uparrow\downarrow$



LaMnO₃/SrMnO₃

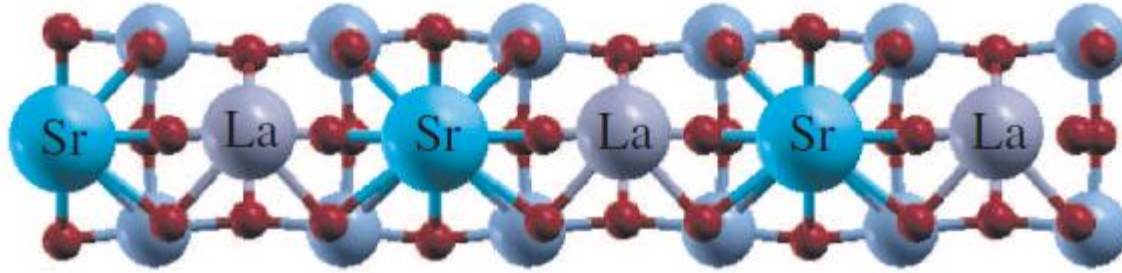
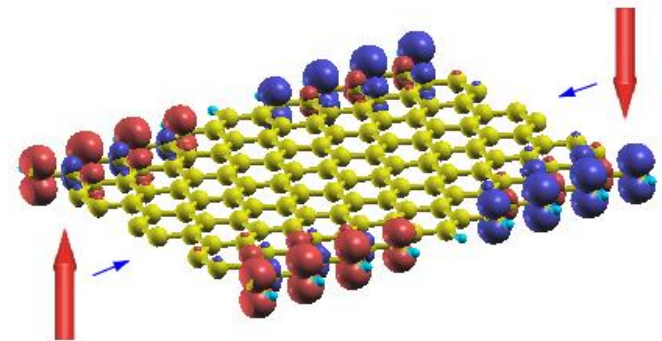
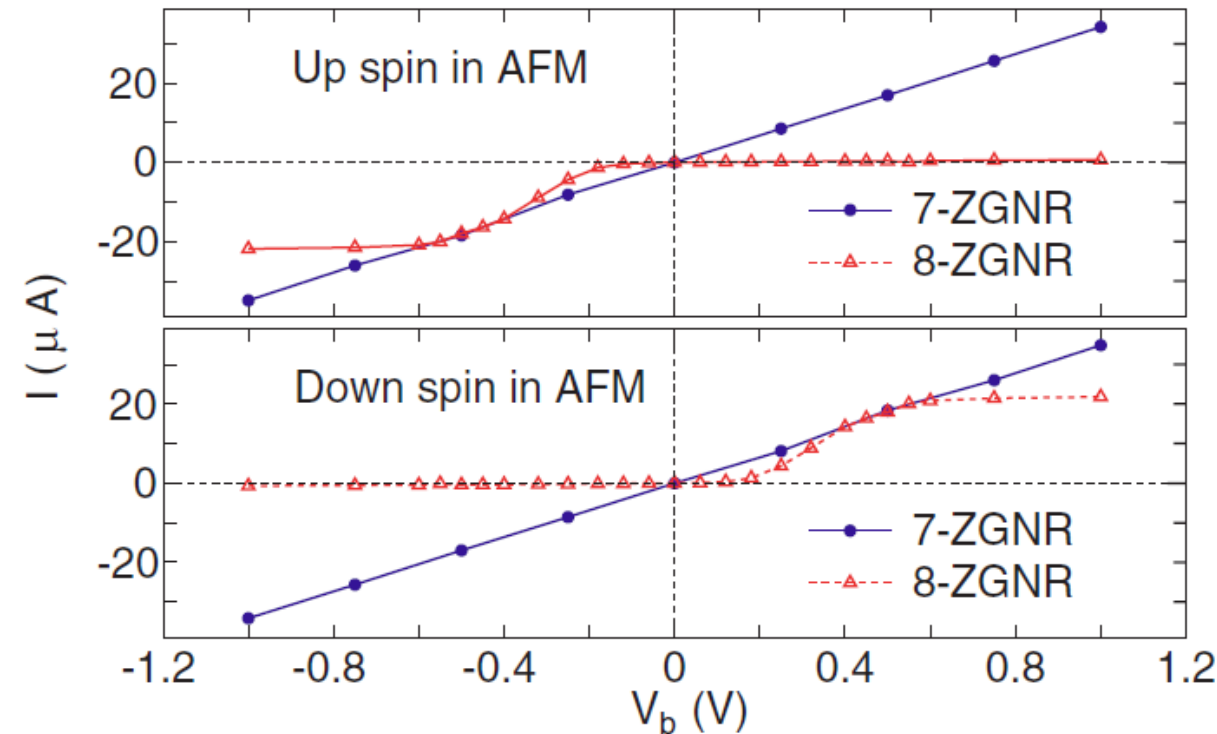


TABLE I: Total energy (meV) per formula unit, LaMnO₃/SrMnO₃, and conductance G ($\Omega^{-1}\mu\text{m}^{-2}$) of the (LaMnO₃)/(SrMnO₃) superlattice with four different magnetic configurations, i.e., ferromagnetic (F), A-type (A), G-type (G), and C-type (C) antiferromagnetic configurations of Mn sites. The total energy is measured relative to that of the ferromagnetic configuration. $G_{\uparrow,\text{in}}$ is the in-plane conductance for the up spin state, and the others are construed in the similar way. For the conductance calculations \mathbf{k} -points of 60×60 were used.

	F	A	C	G
Energy	0	5.0	163.8	248.2
$G_{\uparrow,\text{in}}$	2262	1433	1169	1646
$G_{\downarrow,\text{in}}$	1.82×10^{-2}	1425	1105	1646
$G_{\uparrow,\text{out}}$	1741	664	1127	678
$G_{\downarrow,\text{out}}$	6.43×10^{-3}	655	1128	677

Dual spin filter effect of the magnetic junction

Rectification ratio at 0.4V: 44.3



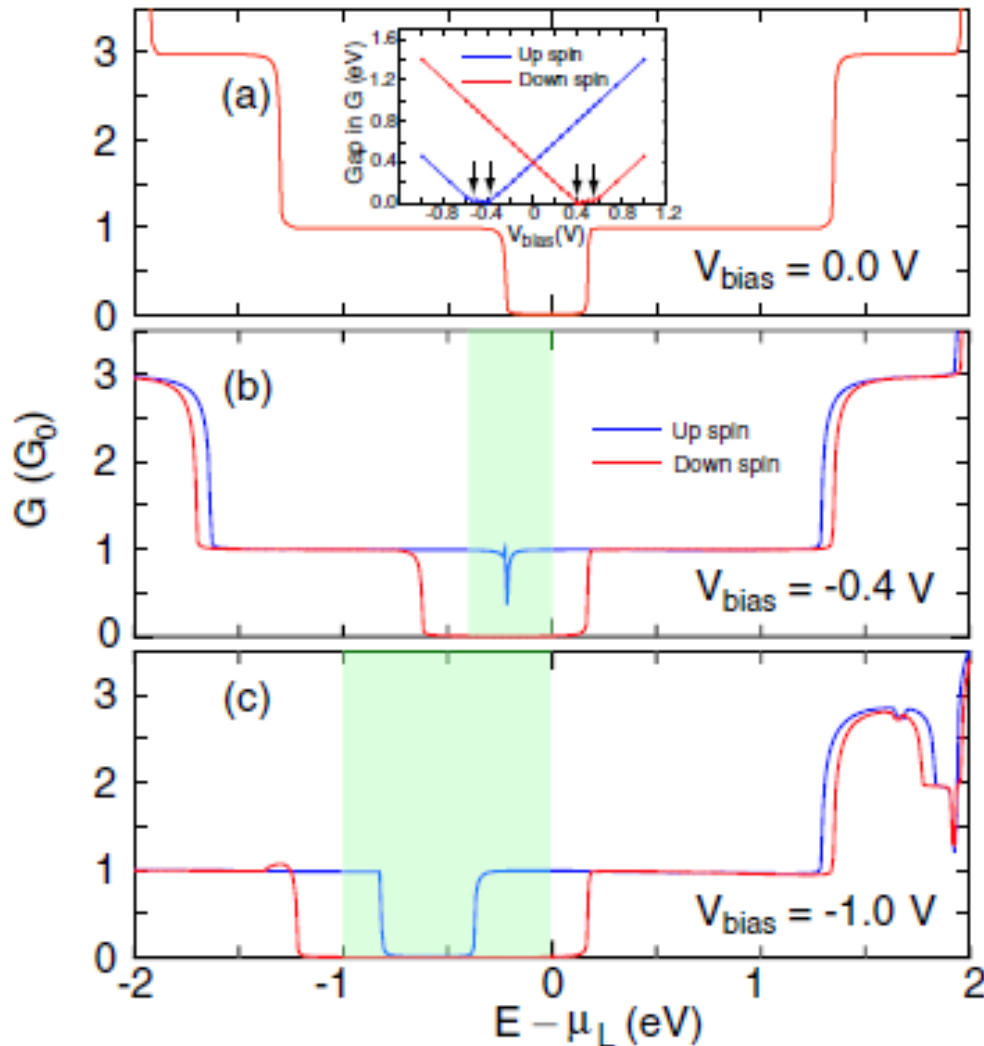
PRB 81, 075422 (2010).

up spin : flowing from right to left
down spin: flowing from left to right

→ Dual spin filter effect

The same result is obtained for 6-ZGNR and 10-ZGNR.

Conductance (transmission) of 8-ZGNR

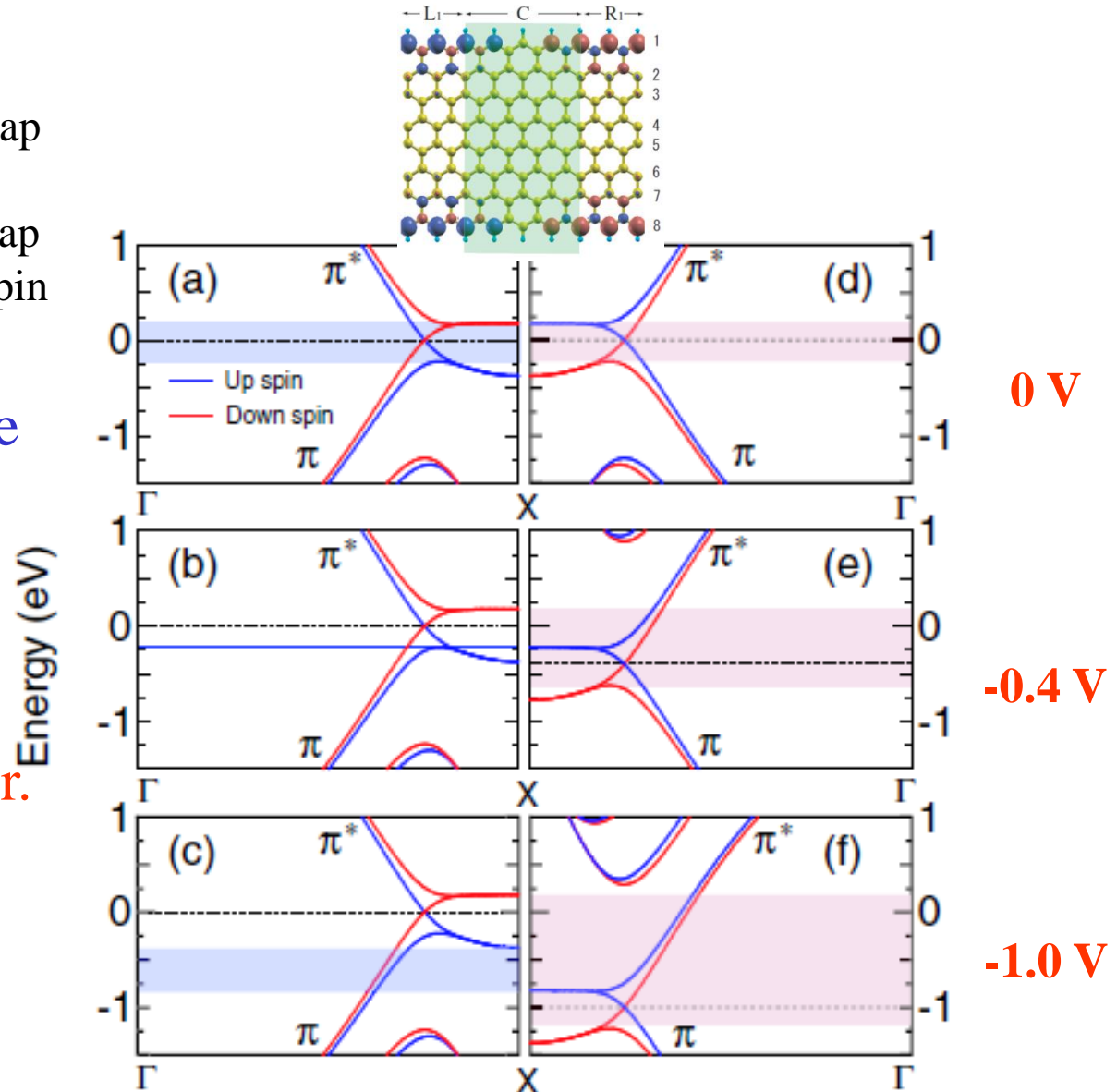


For the up-spin channel, the conduction gap disappears at -0.4 V, while the gap keep increasing for the down spin channel.

Band structures with offset of 8-ZGNR

Blue shade: Conductance gap for the up spin
 Purple shade: Conductance gap for the down spin

The energy regime where the conductance gap appears does correspond to the energy region where **only the π and π^* states overlaps each other.**



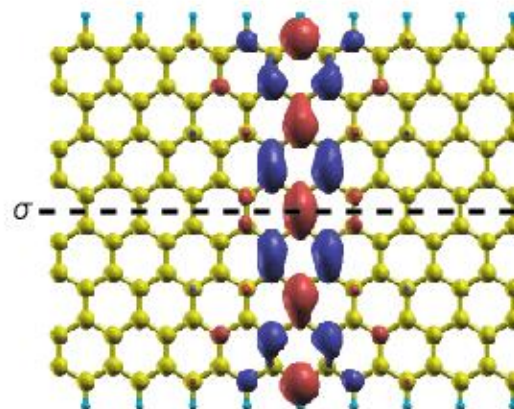
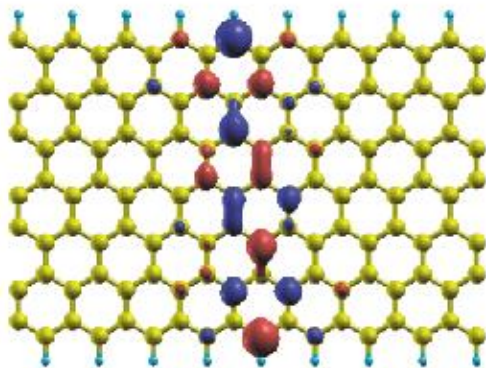
Wannier functions of π and π^* states

calculated from by Marzari's method

7-ZGNR

8-ZGNR

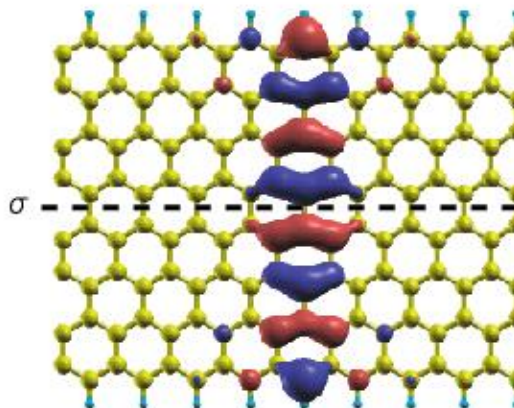
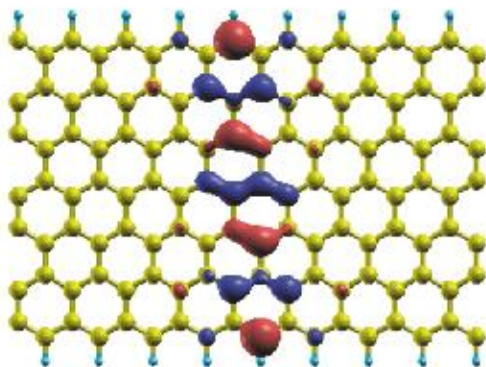
π^*



Symmetric

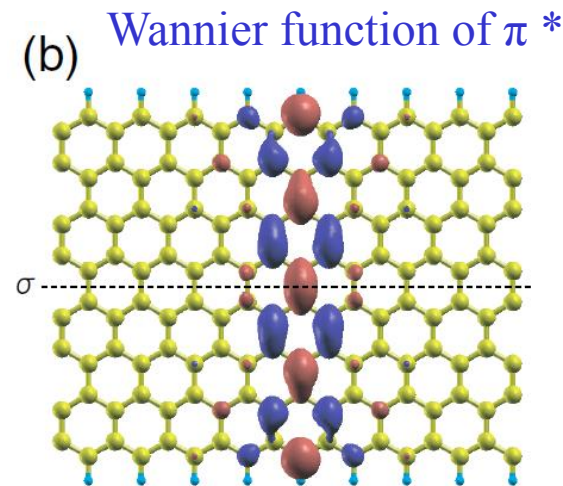
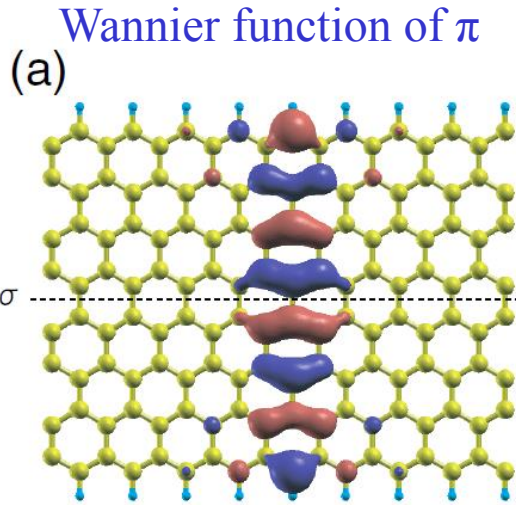
Neither symmetric nor asymmetric

π



Asymmetric

Wannier functions for π and π^* states of 8-ZGNR



Since for 8-ZGNR the π state is asymmetric and the π^* state is symmetric with respect to the σ mirror plane, the hopping integrals are zero.

Hopping integrals calculated by the Wannier functions

TABLE I: Tight-binding parameters (eV) evaluated by WFs denoted by *WF*, and a fitting, denoted by *fitted*, for the π and π^* states of the non-spin polarized 8-ZGNR, where ε is the on-site energy, and $h_1, h_2 \dots$ the nearest and the second nearest neighbor hopping integrals, and so on. The Fermi level is set to zero.

	ε	h_1	h_2	h_3	h_4
π (WF)	-1.3609	-0.7660	0.0076	0.0529	-0.0352
π^* (WF)	1.4486	0.7708	-0.0400	-0.0513	0.0269
π (fitted)	-1.4165	-0.7083	0	0	0
π^* (fitted)	1.4135	0.7067	0	0	0

Since the π and π^* states of 7-ZGNR are neither symmetric nor asymmetric, the corresponding hopping integrals survive.

I-V curve by a TB model

In the simplified TB model the current can be written by

$$I = \int dE (f_L - f_R) T(E),$$

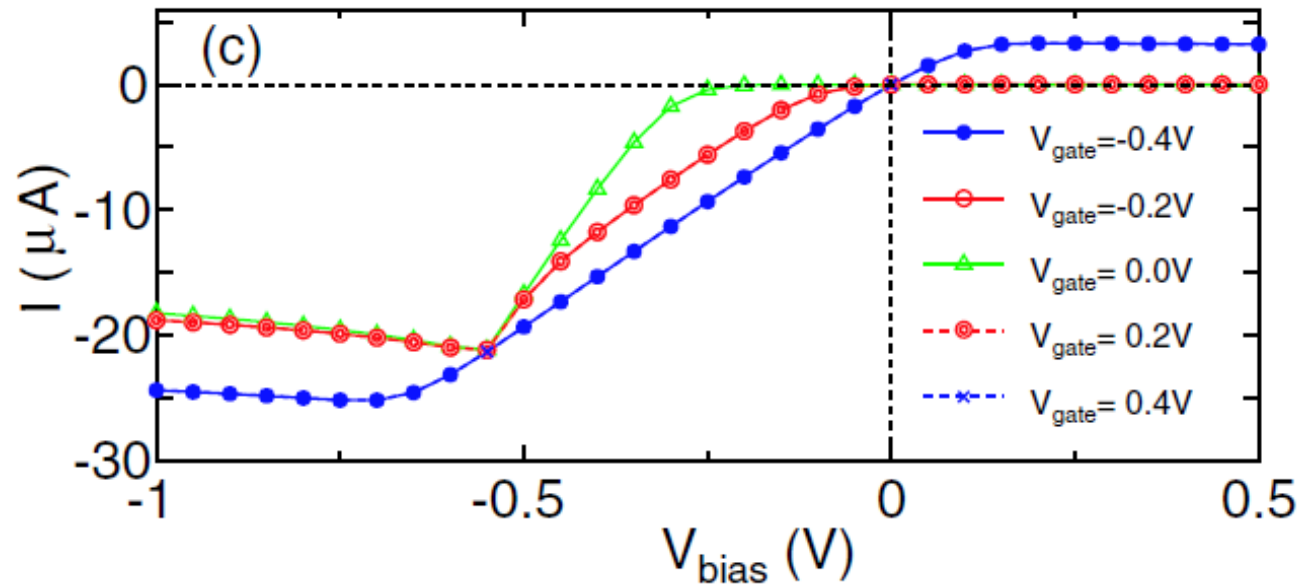
$$T(E) = \frac{4S_L(E)S_R(E)}{[S_L(E) + S_R(E)]^2},$$

$$S_L(E) = \sqrt{4h_1^2 - \left[E - \left(\varepsilon - \frac{1}{2}\Delta_x\right)\right]^2},$$

$$S_R(E) = \sqrt{4h_1^2 - \left[E - \left(\varepsilon + \frac{1}{2}\Delta_x + V_{\text{bias}}\right)\right]^2},$$

I-V by the simplified TB model

The TB model well reproduces the result of the NEGF calculation.



Summary

The NEGF method combined with DFT provides a general framework for a first-principles treatment of electronic transport problems in a sense that

- Equivalent treatment of lead and scattering region
- Self-consistent treatment under finite bias voltage
- Enabling large-scale calculations
- Inclusion of e-p and e-e interactions via self-energy terms

The method can be applicable to a wide variety of materials including nanowires, superlattices, molecular junctions, and carbon nanotubes.